

## General Description

The WSD30L40DN33 is the highest performance trench P-Channel MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSD30L40DN33 meet the RoHS and Green Product requirement 100%  $E_{AS}$  guaranteed with full function reliability approved.

## Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100%  $E_{AS}$  Guaranteed
- Green Device Available

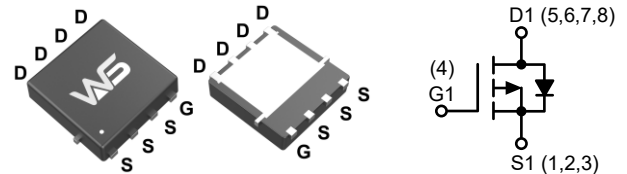
## Product Summary

$BV_{DSS}$	$R_{DS(ON)}$	$I_D$
-30V	11m $\Omega$	-40A

## Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

## DFN3X3-8L Pin Configuration



## Absolute Maximum Ratings

Symbol	Parameter	Rating		Units
		10s	Steady State	
$V_{DS}$	Drain-Source Voltage	-30		V
$V_{GS}$	Gate-Source Voltage	$\pm 20$		
$I_D@T_C=25^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$ <sup>1</sup>	-40		A
$I_D@T_C=100^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$ <sup>1</sup>	-25		
$I_D@T_A=25^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$ <sup>1</sup>	-14.5	-12	
$I_D@T_A=70^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$ <sup>1</sup>	-10.5	-9.8	
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	-70		
$E_{AS}$	Single Pulse Avalanche Energy <sup>3</sup>	81		mJ
$I_{AS}$	Avalanche Current	-18		A
$P_D@T_C=25^\circ C$	Power Dissipation <sup>4</sup>	32.9		W
$P_D@T_A=25^\circ C$	Power Dissipation <sup>4</sup>	3.6	3.1	
$T_{STG}$	Storage Temperature Range	-55 to 150		$^\circ C$
$T_J$	Operating Junction Temperature Range	-55 to 150		

## Thermal Data

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient <sup>1</sup>	---	75	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient <sup>1</sup> ( $t \leq 10s$ )	---	40	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case <sup>1</sup>	---	3.8	

**Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	-30	---	---	V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =-1mA	---	-0.0232	---	V/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A	---	11	14	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-10A	---	18	24	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250μA	-1.3	-1.8	-2.3	V
ΔV <sub>GS(th)</sub>	V <sub>GS(th)</sub> Temperature Coefficient		---	4.6	---	mV/°C
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	---	---	-1.0	μA
		V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C	---	---	-5.0	
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V	---	---	±100	nA
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-30A	---	15	---	S
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f = 1.0MHz	---	9	---	Ω
Q <sub>g</sub>	Total Gate Charge (-4.5V)	V <sub>DS</sub> =-15V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-20A	---	30	---	nC
Q <sub>gs</sub>	Gate-Source Charge		---	1.2	---	
Q <sub>gd</sub>	Gate-Drain Charge		---	11	---	
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> =-15V, V <sub>GS</sub> =-10V, R <sub>G</sub> =6Ω, I <sub>D</sub> =-1A, R <sub>L</sub> =15Ω	---	11	---	ns
T <sub>r</sub>	Rise Time		---	11	---	
T <sub>d(off)</sub>	Turn-Off Delay Time		---	101	---	
T <sub>f</sub>	Fall Time		---	60	---	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f = 1.0MHz	---	1380	---	pF
C <sub>OSS</sub>	Output Capacitance		---	280	---	
C <sub>rss</sub>	Reverse Transfer Capacitance		---	217	---	

**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>5</sup>	V <sub>DD</sub> =-25V, L=0.5mH, I <sub>AS</sub> =-18A	78	---	---	mJ

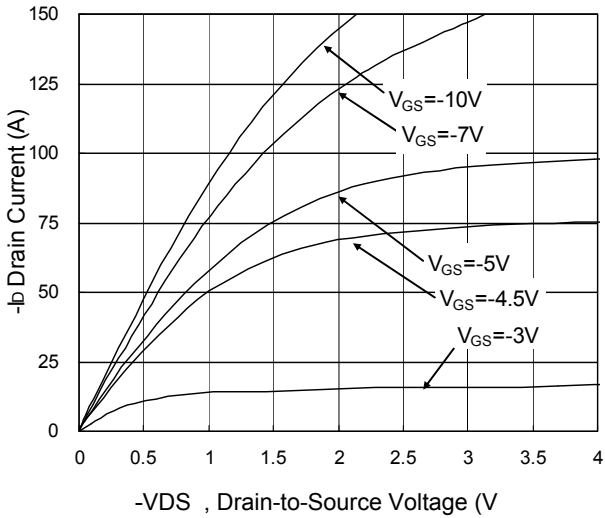
**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
I <sub>S</sub>	Continuous Source Current <sup>1,6</sup>	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	---	---	-20	A
I <sub>SM</sub>	Pulsed Source Current <sup>2,6</sup>		---	---	-70	
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V, I <sub>S</sub> =-1A, T <sub>J</sub> =25°C	---	---	-1.0	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> =-20A, dI/dt=100A/μs, T <sub>J</sub> =25°C	---	20	---	ns
Q <sub>rr</sub>	Reverse Recovery Charge		---	8	---	nC

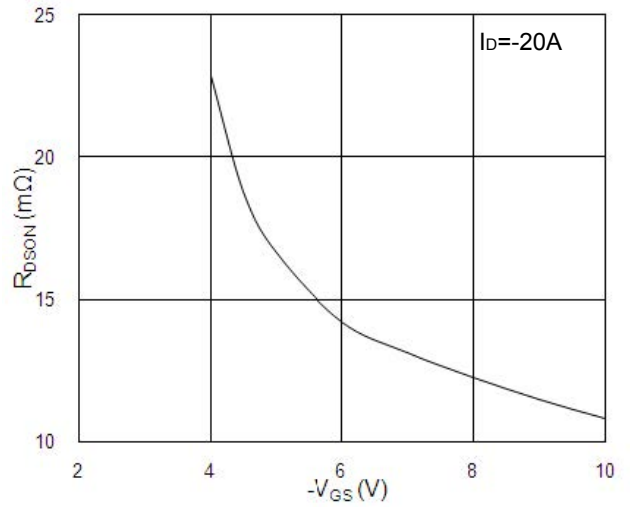
Note:

- The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper, t<sub>s</sub>≤10sec.
- The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%
- The E<sub>AS</sub> data shows Max. rating. The test condition is V<sub>DD</sub>=-25V, V<sub>GS</sub>=-10V, L=0.5mH, I<sub>AS</sub>=-18A
- The power dissipation is limited by 150°C junction temperature.
- The Min. value is 100% E<sub>AS</sub> tested guarantee.
- The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.

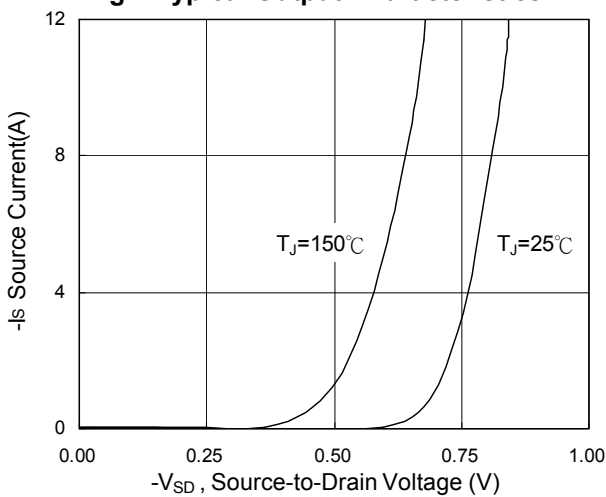
**Typical Characteristics**



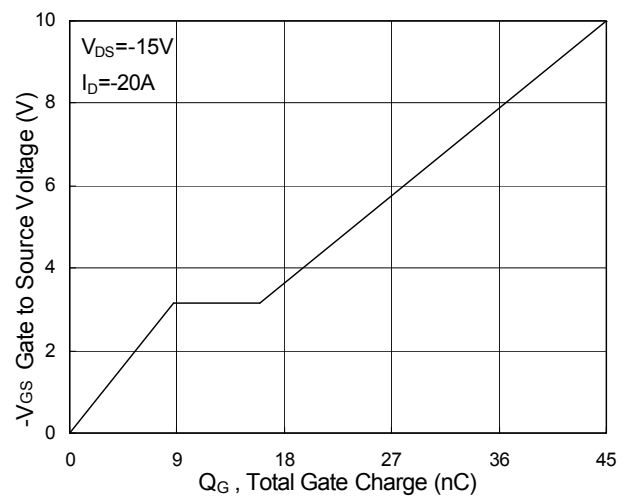
**Fig.1 Typical Output Characteristics**



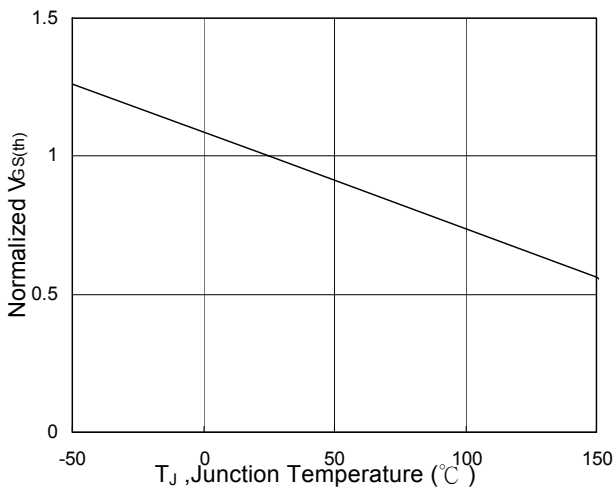
**Fig.2 On-Resistance vs. G-S Voltage**



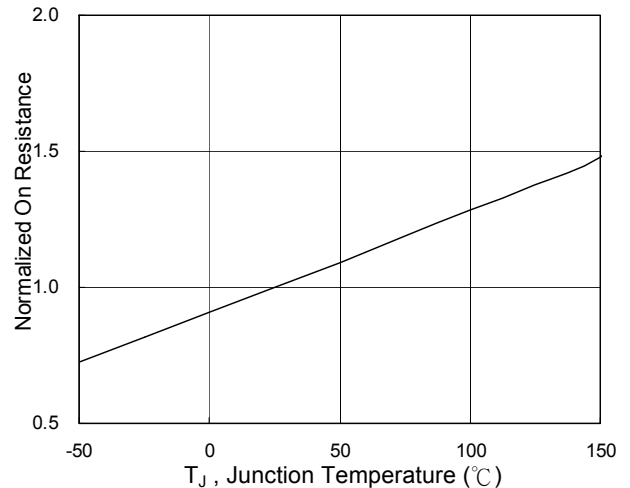
**Fig.3 Forward Characteristics of Reverse**



**Fig.4 Gate-Charge Characteristics**

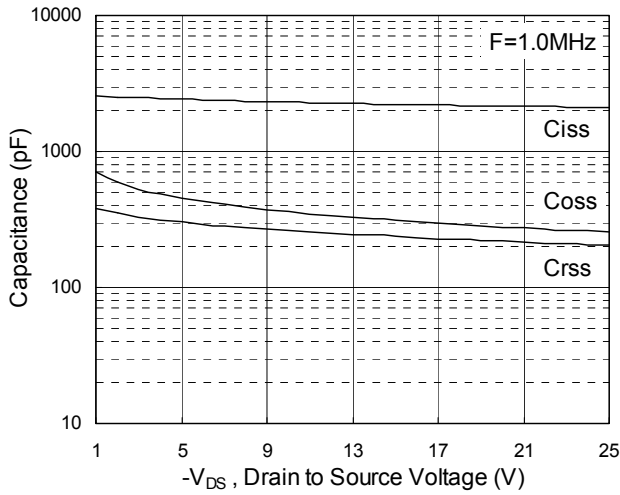


**Fig.5 Normalized V<sub>GS(th)</sub> vs. T<sub>J</sub>**

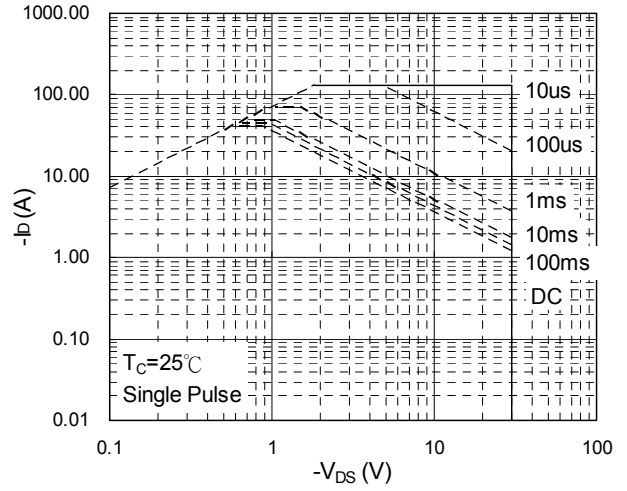


**Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>**

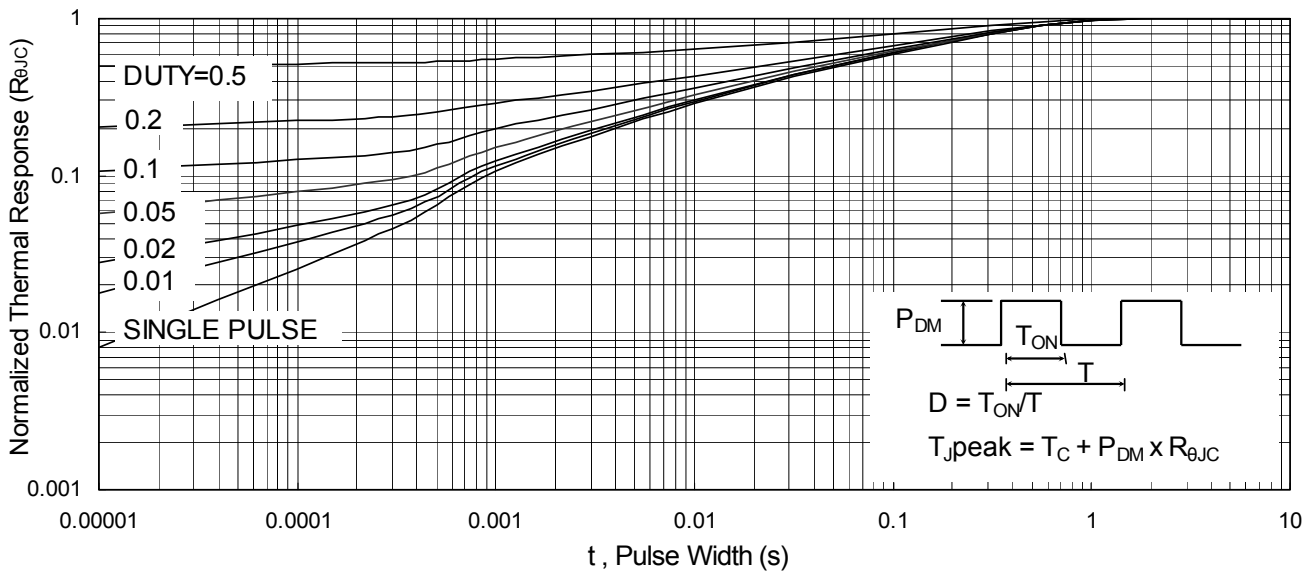
**Typical Characteristics (Cont.)**



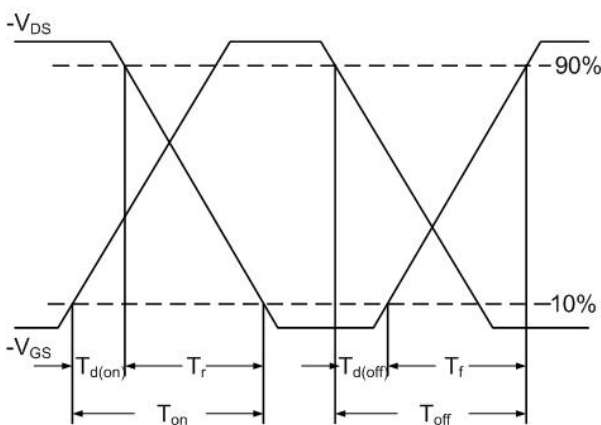
**Fig.7 Capacitance**



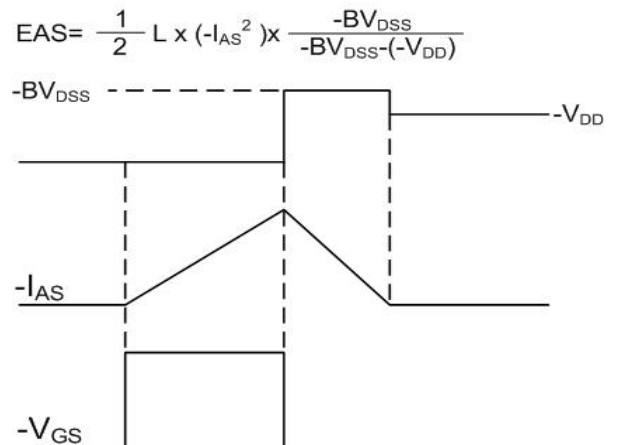
**Fig.8 Safe Operating Area**



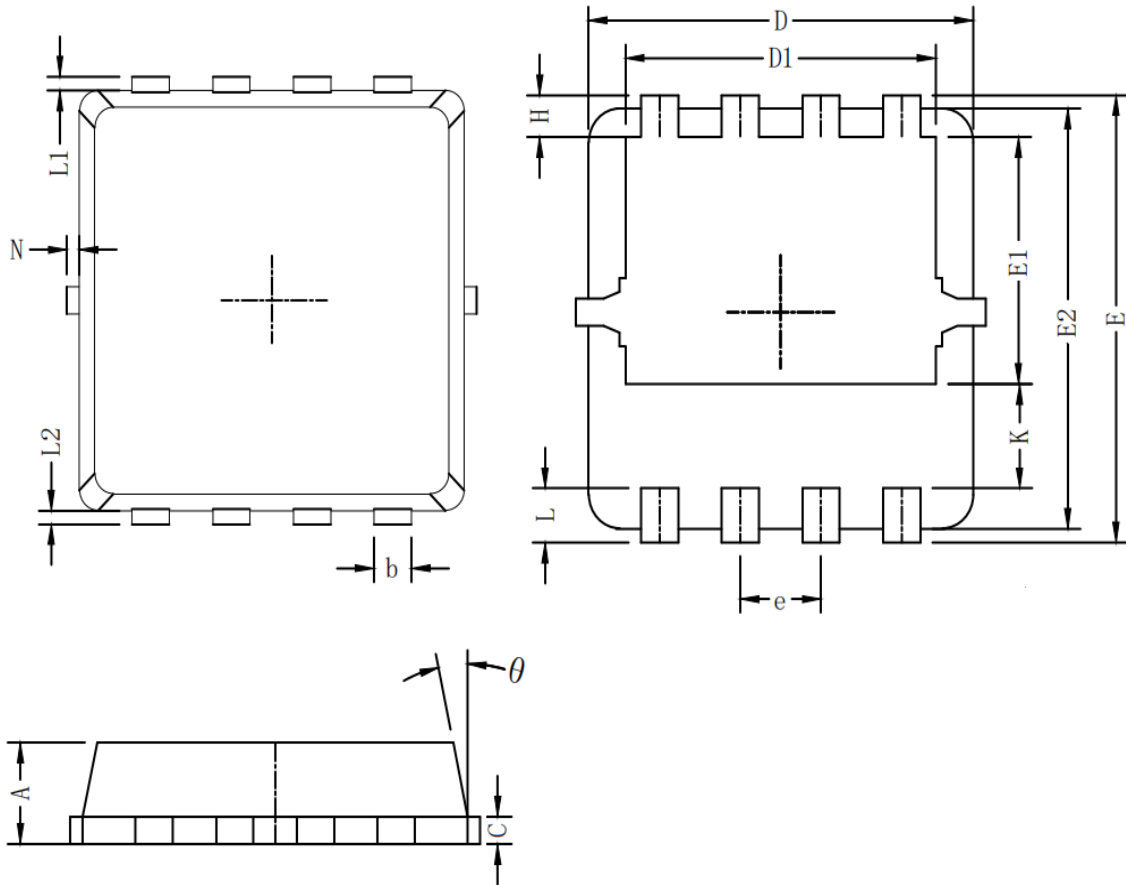
**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**

**Packaging information**


Symbol	Dim in mm		
	min	typ	max
A	0.6	0.75	0.9
b	0.2	0.3	0.4
C	0.15	0.2	0.25
D	3	3.1	3.2
D1	2.3	2.45	2.6
E	3.15	3.3	3.45
E1	1.43	1.73	1.93
E2	2.9	3.05	3.2
e	0.65BSC		
H	0.2	0.35	0.5
K	0.57	0.77	0.87
L	0.3	0.4	0.5
L1/L2	0.1REF		
$\theta$	8°	10°	13°
N	0		0.15

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